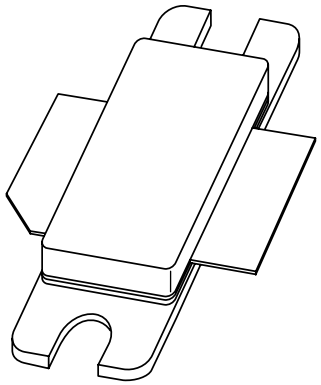
DATA SHEET



BLF2047
UHF power LDMOS transistor

Product specification
Supersedes data of 1999 Jul 01

1999 Dec 02

Philips
Semiconductors

PHILIPS

UHF power LDMOS transistor BLF2047

FEATURES

- High power gain
- Easy power control
- Excellent ruggedness
- Source on underside eliminates DC isolators, reducing common mode inductance
- Designed for broadband operation (1.8 to 2.2 GHz).
- Internal input and output matching for high gain and efficiency

APPLICATIONS

- Common source class-AB operation for PCN and PCS applications in the 1800 to 2200 MHz frequency range.

DESCRIPTION

Silicon N-channel enhancement mode lateral D-MOS transistor encapsulated in a 2-lead flange SOT502A package with a ceramic cap. The common source is connected to the mounting flange.

PINNING

PIN	DESCRIPTION
1	drain
2	gate
3	source connected to flange

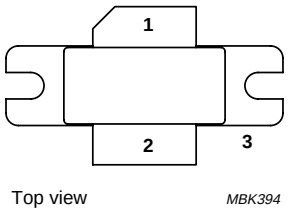


Fig.1 Simplified outline SOT502A.

QUICK REFERENCE DATA

RF performance at T_h = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V_{DS} (V)	P_L (W)	G_p (dB)	η_D (%)	d_{im} (dBc)
Two-tone, class-AB	f_1 = 2200; f_2 = 2200.1	26	65 (PEP)	>10	>30	≤–25
		28	65 (PEP)	typ. 12.6	typ. 31	typ. –29

CAUTION
This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V_{DS}	drain-source voltage	–	65	V
V_{GS}	gate-source voltage	–	±15	V
I_D	DC drain current	–	9	A
T_{stg}	storage temperature	–65	+150	°C
T_j	junction temperature	–	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j\text{-}h}$	thermal resistance from junction to heatsink	T_h = 25 °C, P_{tot} = 152 W, note 1	1.15	K/W

Note

1. Determined under specified RF operating conditions, based on maximum peak junction temperature.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0; I_D = 1.4 mA	65	–	–	V
V_{GSth}	gate-source threshold voltage	V_{DS} = 10 V; I_D = 140 mA	1.5	–	3.5	V
I_{DSS}	drain-source leakage current	V_{GS} = 0; V_{DS} = 26 V	–	–	10	μA
I_{DSX}	on-state drain current	V_{GS} =V_{GSth} + 9 V; V_{DS} = 10 V	18	–	–	A
I_{GSS}	gate leakage current	V_{GS} = ±15 V; V_{DS} = 0	–	–	250	nA
g_{fs}	forward transconductance	V_{DS} = 10 V; I_D = 5 A	–	4	–	S
R_{DSon}	drain-source on-state resistance	V_{GS} =V_{GSth} + 9 V; I_D = 5 A	–	0.17	–	Ω
C_{rss}	feedback capacitance	V_{GS} = 0; V_{DS} = 26 V; f = 1 MHz	–	3.4	–	pF

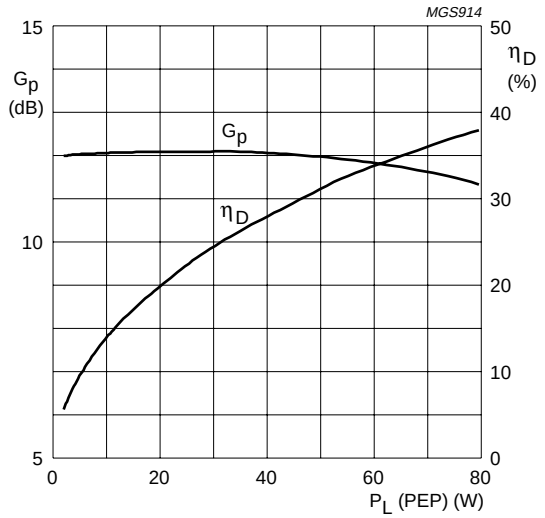
APPLICATION INFORMATION

RF performance in a common source class-AB circuit. T_h = 25 °C; $R_{th\ j\text{-}h}$ = 1.15 K/W; unless otherwise specified.

MODE OF OPERATION	f (MHz)	V_{DS} (V)	I_{DQ} (mA)	P_L (W)	G_p (dB)	η_D (%)	d_{im} (dBc)
Two-tone, class-AB	f_1 = 2200; f_2 = 2200.1	26	400	65 (PEP)	>10	>30	≤–25
		28	400	65 (PEP)	typ. 12.6	typ. 31	typ. –29

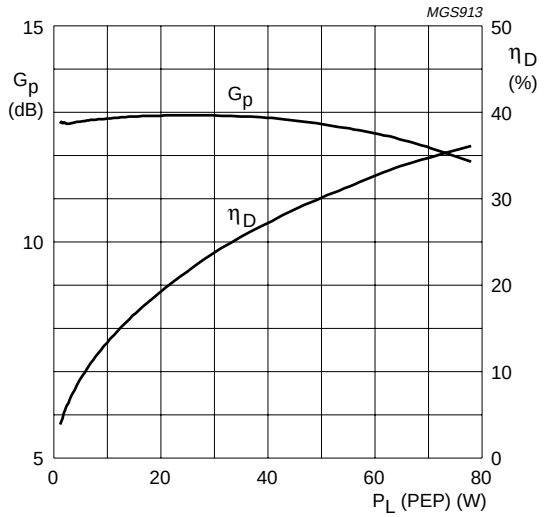
Ruggedness in class-AB operation

The BLF2047 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 26 V; I_{DQ} = 400 mA; P_L = 65 W (CW); f = 2200 MHz.



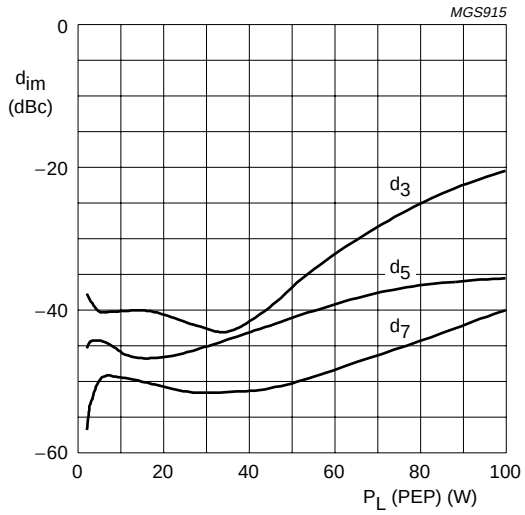
V_{DS} = 26 V; I_{DQ} = 400 mA; $T_h \leq 25$ °C;
f_1 = 2000 MHz; f_2 = 2000.1 MHz.

Fig.2 Power gain and drain efficiency as functions of peak envelope load power; typical values.



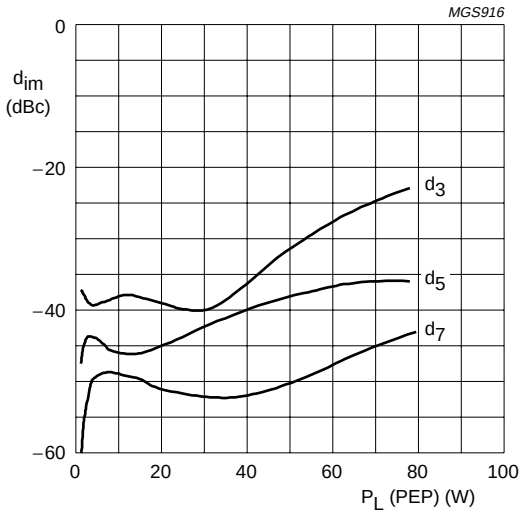
V_{DS} = 26 V; I_{DQ} = 400 mA; $T_h \leq 25$ °C;
f_1 = 2200 MHz; f_2 = 2200.1 MHz.

Fig.3 Power gain and drain efficiency as functions of peak envelope load power; typical values.



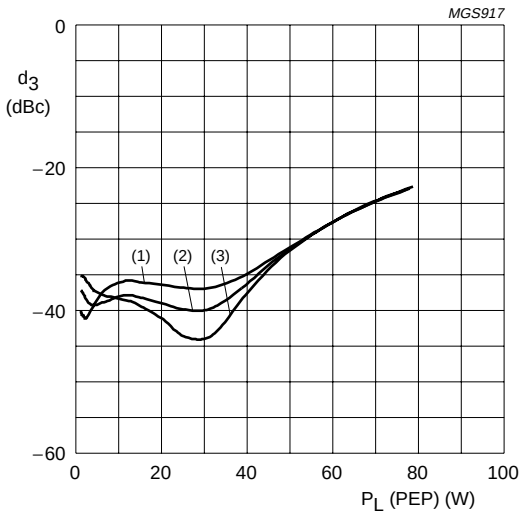
V_{DS} = 26 V; I_{DQ} = 400 mA; $T_h \leq 25$ °C;
f_1 = 2000 MHz; f_2 = 2000.1 MHz.

Fig.4 Intermodulation distortion as a function of peak envelope load power; typical values.



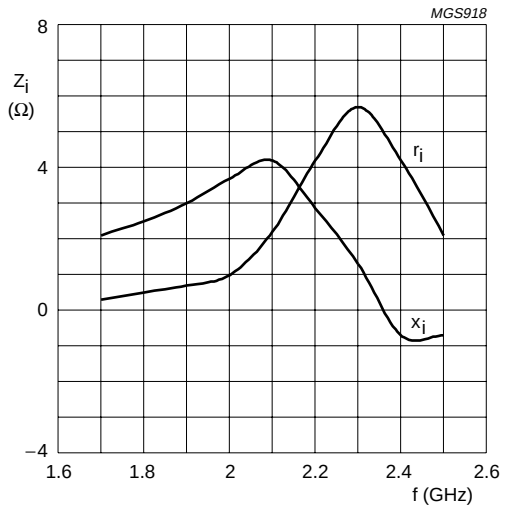
V_{DS} = 26 V; I_{DQ} = 400 mA; $T_h \leq 25$ °C;
f_1 = 2200 MHz; f_2 = 2200.1 MHz.

Fig.5 Intermodulation distortion as a function of peak envelope load power; typical values.



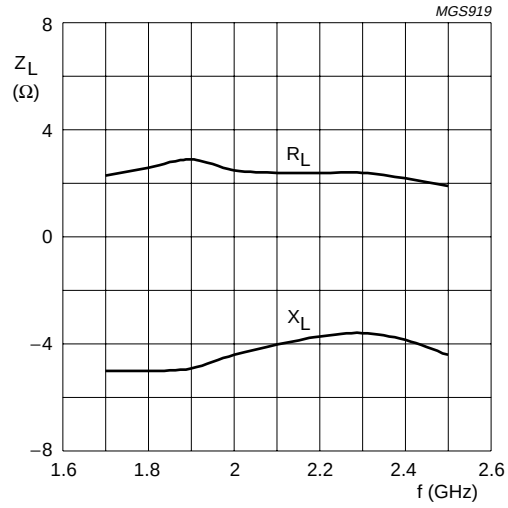
V_{DS} = 26 V; $T_h \leq 25$ °C; f_1 = 2200 MHz; f_2 = 2200.1 MHz.
(1) I_{DQ} = 350 mA.
(2) I_{DQ} = 400 mA.
(3) I_{DQ} = 450 mA.

Fig.6 Intermodulation distortion as a function of peak envelope load power; typical values.



V_{DS} = 26 V; I_{DQ} = 400 mA; P_L = 80 W; $T_h \leq 25$ °C.

Fig.7 Input impedance as a function of frequency (series components); typical values.



V_{DS} = 26 V; I_{DQ} = 400 mA; P_L = 80 W; $T_h \leq 25$ °C.

Fig.8 Load impedance as a function of frequency (series components); typical values.

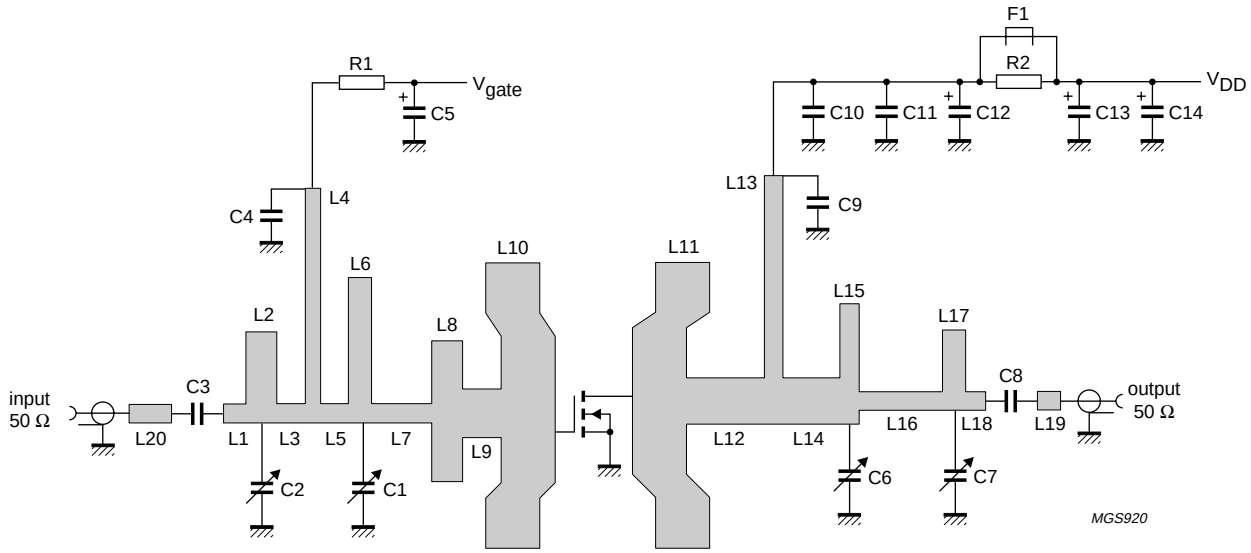


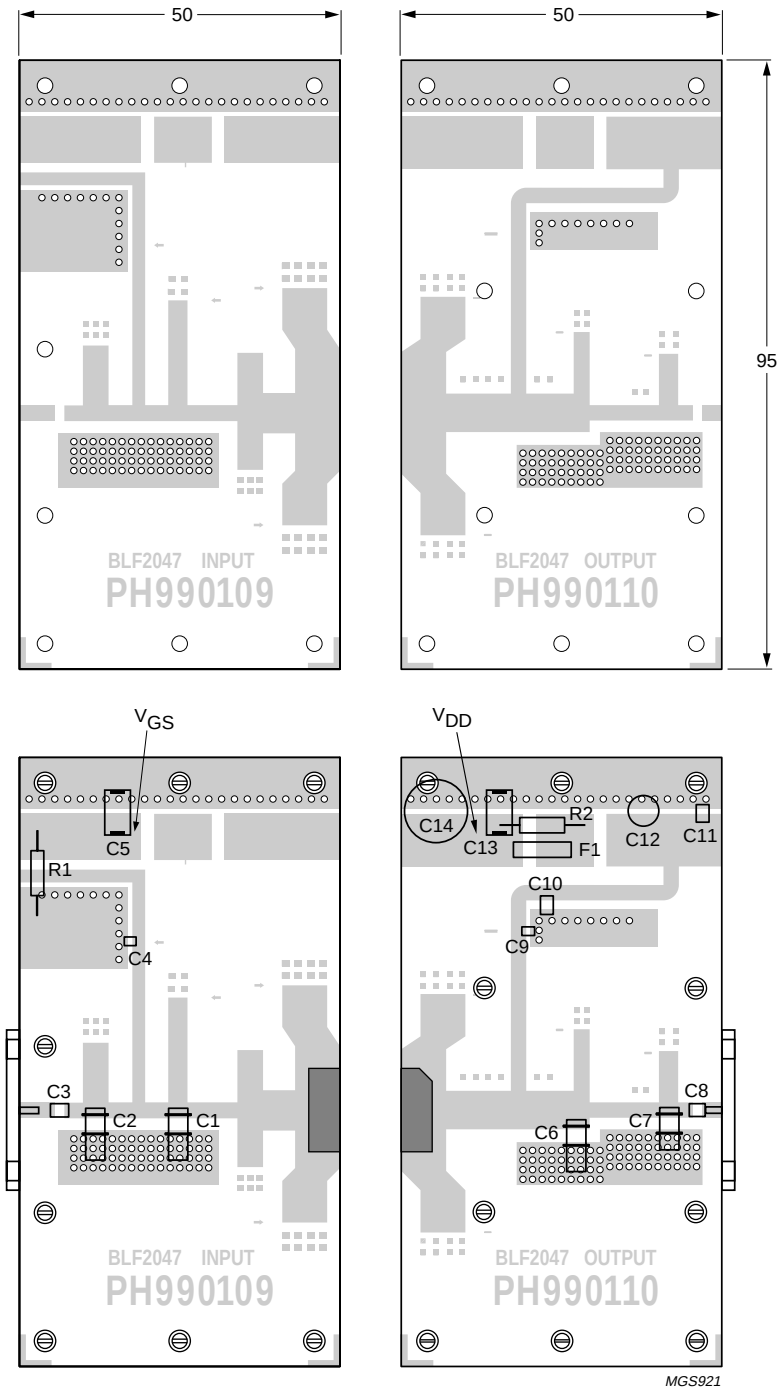
Fig.9 Class-AB test circuit at f = 2.2 GHz.

List of components (See Figs 9 and 10)

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C2, C6, C7	Tekelec variable capacitor; type 37281	0.4 to 2.5 pF		
C3, C8	multilayer ceramic chip capacitor; note 1	12 pF		
C4, C9	multilayer ceramic chip capacitor; note 2	12 pF		
C5, C12	electrolytic capacitor	10 μF; 100 V		2222 037 59109
C10	multilayer ceramic chip capacitor; note 1	1 nF		
C11	multilayer ceramic chip capacitor	100 nF		2222 581 16641
C13	tantal SMD capacitor	4.5 μF; 50 V		
C14	electrolytic capacitor	100 μF; 63 V		2222 037 58101
F1	Ferroxcube chip-bead 8DS3/3/8/9-4S2			4330 030 36301
L1	stripline; note 3	50 Ω	2.9 × 2.4 mm	
L2	stripline; note 3	14.5 Ω	4 × 11.7 mm	
L3	stripline; note 3	50 Ω	3.7 × 2.4 mm	
L4	stripline; note 3	6 Ω	2 × 30.8 mm	
L5	stripline; note 3	50 Ω	3.6 × 2.4 mm	
L6	stripline; note 3	9.5 Ω	3 × 18.8 mm	
L7	stripline; note 3	50 Ω	7.8 × 2.4 mm	
L8	stripline; note 3	9.8 Ω	4 × 18.3 mm	
L9	stripline; note 3	24.4 Ω	5 × 6.3 mm	
L10, L11	stripline; note 3	5.1 Ω	7 × 37 mm	
L12	stripline; note 3	25.4 Ω	10.1 × 6 mm	
L13	stripline; note 3	5.7 Ω	2.4 × 32.8 mm	
L14	stripline; note 3	25.4 Ω	7.4 × 6 mm	
L15	stripline; note 3	11.3 Ω	2.5 × 15.6 mm	
L16	stripline; note 3	50 Ω	10.8 × 2.4 mm	
L17	stripline; note 3	16.1 Ω	3 × 10.4 mm	
L18	stripline; note 3	50 Ω	2.3 × 2.4 mm	
L19	stripline; note 3	50 Ω	3 × 2.4 mm	
L20	stripline; note 3	50 Ω	5.5 × 2.4 mm	
R1, R2	metal film resistor	10 Ω, 0.6 W		2322 156 11009

Notes

1. American Technical Ceramics type 100B or capacitor of same quality.
2. American Technical Ceramics type 100A or capacitor of same quality.
3. The striplines are on a double copper-clad printed-circuit board with Teflon dielectric (ε_r = 2.2); thickness 0.79 mm.



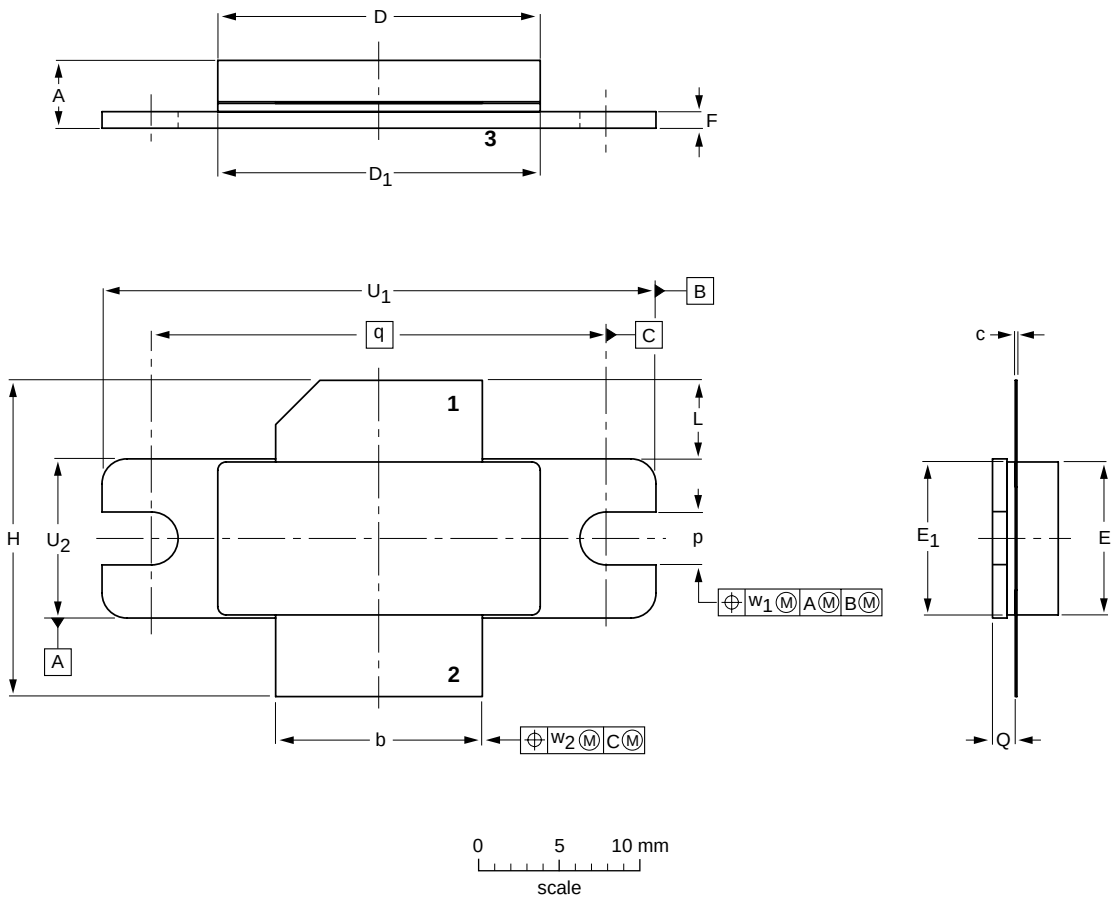
Dimensions in mm.

The components are situated on one side of the copper-clad printed-circuit board with Teflon dielectric (ε_r = 2.2), thickness 0.79 mm. The other side is unetched and serves as a ground plane.

Fig.10 Component layout for 2.2 GHz class-AB test circuit.

PACKAGE OUTLINE

Flanged LDMOST package; 2 mounting holes; 2 leads **SOT502A**



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	c	D	D_1	E	E_1	F	H	L	p	Q	q	U_1	U_2	w_1	w_2
mm	4.72 3.99	12.83 12.57	0.15 0.08	20.02 19.61	19.96 19.66	9.50 9.30	9.53 9.25	1.14 0.89	19.94 18.92	5.33 4.32	3.38 3.12	1.70 1.45	27.94	34.16 33.91	9.91 9.65	0.25	0.51
inches	0.186 0.157	0.505 0.495	0.006 0.003	0.788 0.772	0.786 0.774	0.374 0.366	0.375 0.364	0.045 0.035	0.785 0.745	0.210 0.170	0.133 0.123	0.067 0.057	1.100	1.345 1.335	0.390 0.380	0.01	0.02

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT502A						~~99-06-07~~ 99-10-13

DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

NOTES

Philips Semiconductors – a worldwide company

Argentina: see South America

Australia: 3 Figtree Drive, HOMEBUSH, NSW 2140,
Tel. +61 2 9704 8141, Fax. +61 2 9704 8139

Austria: Computerstr. 6, A-1101 WIEN, P.O. Box 213,
Tel. +43 1 60 101 1248, Fax. +43 1 60 101 1210

Belarus: Hotel Minsk Business Center, Bld. 3, r. 1211, Volodarski Str. 6,
220050 MINSK, Tel. +375 172 20 0733, Fax. +375 172 20 0773

Belgium: see The Netherlands

Brazil: see South America

Bulgaria: Philips Bulgaria Ltd., Energoproject, 15th floor,
51 James Bourchier Blvd., 1407 SOFIA,
Tel. +359 2 68 9211, Fax. +359 2 68 9102

Canada: PHILIPS SEMICONDUCTORS/COMPONENTS,
Tel. +1 800 234 7381, Fax. +1 800 943 0087

China/Hong Kong: 501 Hong Kong Industrial Technology Centre,
72 Tat Chee Avenue, Kowloon Tong, HONG KONG,
Tel. +852 2319 7888, Fax. +852 2319 7700

Colombia: see South America

Czech Republic: see Austria

Denmark: Sydhavnsgade 23, 1780 COPENHAGEN V,
Tel. +45 33 29 3333, Fax. +45 33 29 3905

Finland: Sinikalliontie 3, FIN-02630 ESPOO,
Tel. +358 9 615 800, Fax. +358 9 6158 0920

France: 51 Rue Carnot, BP317, 92156 SURESNES Cedex,
Tel. +33 1 4099 6161, Fax. +33 1 4099 6427

Germany: Hammerbrookstraße 69, D-20097 HAMBURG,
Tel. +49 40 2353 60, Fax. +49 40 2353 6300

Hungary: see Austria

India: Philips INDIA Ltd, Band Box Building, 2nd floor,
254-D, Dr. Annie Besant Road, Worli, MUMBAI 400 025,
Tel. +91 22 493 8541, Fax. +91 22 493 0966

Indonesia: PT Philips Development Corporation, Semiconductors Division,
Gedung Philips, Jl. Buncit Raya Kav.99-100, JAKARTA 12510,
Tel. +62 21 794 0040 ext. 2501, Fax. +62 21 794 0080

Ireland: Newstead, Clonskeagh, DUBLIN 14,
Tel. +353 1 7640 000, Fax. +353 1 7640 200

Israel: RAPAC Electronics, 7 Kehilat Saloniki St, PO Box 18053,
TEL AVIV 61180, Tel. +972 3 645 0444, Fax. +972 3 649 1007

Italy: PHILIPS SEMICONDUCTORS, Via Casati, 23 - 20052 MONZA (MI),
Tel. +39 039 203 6838, Fax +39 039 203 6800

Japan: Philips Bldg 13-37, Kohnan 2-chome, Minato-ku,
TOKYO 108-8507, Tel. +81 3 3740 5130, Fax. +81 3 3740 5057

Korea: Philips House, 260-199 Itaewon-dong, Yongsan-ku, SEOUL,
Tel. +82 2 709 1412, Fax. +82 2 709 1415

Malaysia: No. 76 Jalan Universiti, 46200 PETALING JAYA, SELANGOR,
Tel. +60 3 750 5214, Fax. +60 3 757 4880

Mexico: 5900 Gateway East, Suite 200, EL PASO, TEXAS 79905,
Tel. +9-5 800 234 7381, Fax +9-5 800 943 0087

Middle East: see Italy

Netherlands: Postbus 90050, 5600 PB EINDHOVEN, Bldg. VB,
Tel. +31 40 27 82785, Fax. +31 40 27 88399

New Zealand: 2 Wagener Place, C.P.O. Box 1041, AUCKLAND,
Tel. +64 9 849 4160, Fax. +64 9 849 7811

Norway: Box 1, Manglerud 0612, OSLO,
Tel. +47 22 74 8000, Fax. +47 22 74 8341

Pakistan: see Singapore

Philippines: Philips Semiconductors Philippines Inc.,
106 Valero St. Salcedo Village, P.O. Box 2108 MCC, MAKATI,
Metro MANILA, Tel. +63 2 816 6380, Fax. +63 2 817 3474

Poland: Al.Jerozolimskie 195 B, 02-222 WARSAW,
Tel. +48 22 5710 000, Fax. +48 22 5710 001

Portugal: see Spain

Romania: see Italy

Russia: Philips Russia, Ul. Usatcheva 35A, 119048 MOSCOW,
Tel. +7 095 755 6918, Fax. +7 095 755 6919

Singapore: Lorong 1, Toa Payoh, SINGAPORE 319762,
Tel. +65 350 2538, Fax. +65 251 6500

Slovakia: see Austria

Slovenia: see Italy

South Africa: S.A. PHILIPS Pty Ltd., 195-215 Main Road Martindale,
2092 JOHANNESBURG, P.O. Box 58088 Newville 2114,
Tel. +27 11 471 5401, Fax. +27 11 471 5398

South America: Al. Vicente Pinzon, 173, 6th floor,
04547-130 SÃO PAULO, SP, Brazil,
Tel. +55 11 821 2333, Fax. +55 11 821 2382

Spain: Balmes 22, 08007 BARCELONA,
Tel. +34 93 301 6312, Fax. +34 93 301 4107

Sweden: Kottbygatan 7, Akalla, S-16485 STOCKHOLM,
Tel. +46 8 5985 2000, Fax. +46 8 5985 2745

Switzerland: Allmendstrasse 140, CH-8027 ZÜRICH,
Tel. +41 1 488 2741 Fax. +41 1 488 3263

Taiwan: Philips Semiconductors, 6F, No. 96, Chien Kuo N. Rd., Sec. 1,
TAIPEI, Taiwan Tel. +886 2 2134 2886, Fax. +886 2 2134 2874

Thailand: PHILIPS ELECTRONICS (THAILAND) Ltd.,
209/2 Sanpavuth-Bangna Road Prakanong, BANGKOK 10260,
Tel. +66 2 745 4090, Fax. +66 2 398 0793

Turkey: Yukari Dudullu, Org. San. Blg., 2.Cad. Nr. 28 81260 Umraniye,
ISTANBUL, Tel. +90 216 522 1500, Fax. +90 216 522 1813

Ukraine: PHILIPS UKRAINE, 4 Patrice Lumumba str., Building B, Floor 7,
252042 KIEV, Tel. +380 44 264 2776, Fax. +380 44 268 0461

United Kingdom: Philips Semiconductors Ltd., 276 Bath Road, Hayes,
MIDDLESEX UB3 5BX, Tel. +44 208 730 5000, Fax. +44 208 754 8421

United States: 811 East Arques Avenue, SUNNYVALE, CA 94088-3409,
Tel. +1 800 234 7381, Fax. +1 800 943 0087

Uruguay: see South America

Vietnam: see Singapore

Yugoslavia: PHILIPS, Trg N. Pasica 5/v, 11000 BEOGRAD,
Tel. +381 11 62 5344, Fax.+381 11 63 5777

For all other countries apply to: Philips Semiconductors,
International Marketing & Sales Communications, Building BE-p, P.O. Box 218,
5600 MD EINDHOVEN, The Netherlands, Fax. +31 40 27 24825

Internet: http://www.semiconductors.philips.com

Printed in The Netherlands 125002/04/pp12 Date of release: 1999 Dec 02 Document order number: 9397 750 06449

Let's make things better.

Philips Semiconductors

PHILIPS